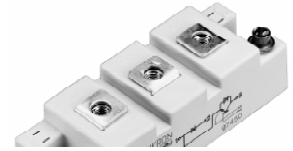


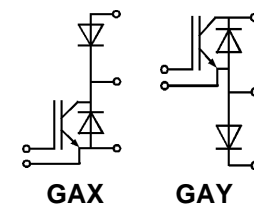
Absolute Maximum Ratings		Values		Units
Symbol	Conditions ¹⁾			
V _{CES}		1700		V
V _{CGR}	R _{GE} = 20 kΩ	1700		V
I _C	T _{case} = 25/80 °C	110 / 75		A
I _{CM}	T _{case} = 25/80 °C; t _p = 1 ms	220 / 150		A
V _{GES}		± 20		V
P _{tot}	per IGBT/Diode, T _{case} = 25 °C	625 / 310		W
T _J , (T _{stg})		-40 ... +150 (125)		°C
V _{isol}	AC, 1 min.	4000		V
humidity	DIN 40 040	Class F		
climate	DIN IEC 68 T.1	40/125/56		
Diode ⁸⁾		Inverse	Series ⁶⁾	
I _F = -I _C	T _{case} = 25/80 °C	80 / 50	125 / 80	A
I _{FM} = -I _{CM}	T _{case} = 25/80 °C; t _p = 1 ms	200 / 150	250 / 160	A
I _{FSM}	t _p = 10 ms; sin.; T _J = 150 °C	720	1100	A
I ² t	t _p = 10 ms; T _J = 150 °C	2600	6000	A ² s

SEMITRANS® M IGBT Modules

SKM 100 GAX 173 D ⁶⁾
SKM 100 GAY 173 D ⁶⁾



SEMITRANS 2



Features

- N channel, Homogeneous Silicon structure (NPT-IGBT)
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to 6 * I_{Cnom}
- Latch-up free
- Fast & soft inverse CAL diodes ⁸⁾
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (10 mm) and creepage distances (20 mm).

Typical Applications

- Bidirectional switches as "reverse blocking" IGBT
- Regenerative Braking
- Quasi resonant inverters
- DC bus voltage 750 - 1200 V_{DC}
- Public transport (auxiliary syst.)
- Switching (not for linear use)

Characteristics		min.	typ.	max.	Units
Symbol	Conditions ¹⁾				
V _{(BR)CES}	V _{GE} = 0, I _C = 1,4 mA	≥ V _{CES}	-	-	V
V _{GE(th)}	V _{GE} = V _{CE} , I _C = 6 mA	4,8	5,5	6,2	V
I _{CES}	V _{GE} = 0 } T _J = 25 °C V _{CE} = V _{CES} } T _J = 125 °C	-	0,1	1	mA
I _{GES}	V _{GE} = 20 V, V _{CE} = 0	-	-	400	nA
V _{CESat}	I _C = 75 A } V _{GE} = 15 V; V _{CESat} } T _J = 25 (125) °C	-	3,4(4,4)	3,9(5)	V
V _{CESat}	I _C = 100 A } V _{GE} = 15 V; V _{CESat} } T _J = 25 (125) °C	-	3,8(5,5)	-	V
g _{fs}	V _{CE} = 20 V, I _C = 75 A	27	-	-	S
C _{CHC}	per IGBT	-	-	200	pF
C _{ies}	V _{GE} = 0	-	11	-	nF
C _{oes}	V _{CE} = 25 V	-	1	-	nF
C _{res}	f = 1 MHz	-	0,28	-	nF
L _{CE}		-	-	30	nH
t _{d(on)}	V _{CC} = 1200 V	-	40	-	ns
t _r	V _{GE} = +15 V / -15 V	-	45	-	ns
t _{d(off)}	I _C = 75 A, ind. load	-	400	-	ns
t _f	R _{Gon} = R _{Goff} = 10 Ω	-	56	-	ns
E _{on}	T _J = 125 °C	-	35	-	mWs
E _{off}		-	21	-	mWs
Inverse Diode ⁸⁾					
V _F = V _{EC}	I _F = 75 A } V _{GE} = 0 V; V _F = V _{EC} } T _J = 25 (125) °C	-	2,2(2,0)	2,7(2,3)	V
V _F = V _{EC}	I _F = 100 A } V _{GE} = 0 V; V _F = V _{EC} } T _J = 25 (125) °C	-	2,45(2,25)	-	V
V _{TO}	T _J = 125 °C	-	1,3	1,5	V
r _T	T _J = 125 °C	-	9	13	mΩ
I _{RRM}	I _F = 75 A; T _J = 25 (125) °C ²⁾	-	38(51)	-	A
Q _{rr}	I _F = 75 A; T _J = 25 (125) °C ²⁾	-	8(19)	-	μC
Series Diode ^{6), 8)}					
V _F = V _{EC}	I _F = 100 A } V _{GE} = 0 V; V _F = V _{EC} } T _J = 25 (125) °C	-	2,2(1,9)	2,7(2,4)	V
V _F = V _{EC}	I _F = 150 A } V _{GE} = 0 V; V _F = V _{EC} } T _J = 25 (125) °C	-	2,4(2,2)	-	V
V _{TO}	T _J = 125 °C	-	1,2	1,5	V
r _T	T _J = 125 °C	-	7	9	mΩ
I _{RR}	I _F = 100 A; T _J = 25 (125) °C ²⁾	-	50(70)	-	A
Q _{rr}	I _F = 100 A; T _J = 25 (125) °C ²⁾	-	10(27)	-	μC
Thermal characteristics					
R _{thjc}	per IGBT	-	-	0,2	°C/W
R _{thjc}	per inverse/series diode	-	-	0,63/0,40	°C/W
R _{thch}	per module	-	-	0,05	°C/W

¹⁾ T_{case} = 25 °C, unless otherwise specified

²⁾ I_F = -I_C, V_R = 1200 V, - di_F/dt = 800 A/μs, V_{GE} = 0 V

⁶⁾ The series diodes have the data of the inverse diodes of SKM 150 GB 173 D

⁸⁾ CAL = Controlled Axial Lifetime Technology.

Cases and mech. data
→ B6 – 246

Diagrams of IGBT

→ B 6 – 240...

of series diode → B 6 – 250
fig. 17, 18, 20 to 24.

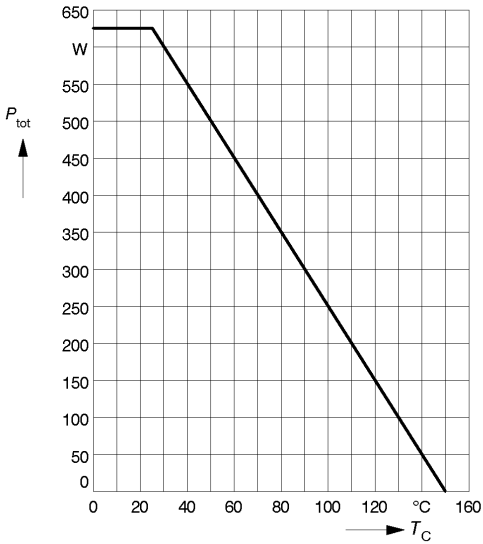


Fig. 1 Rated power dissipation $P_{tot} = f(T_C)$

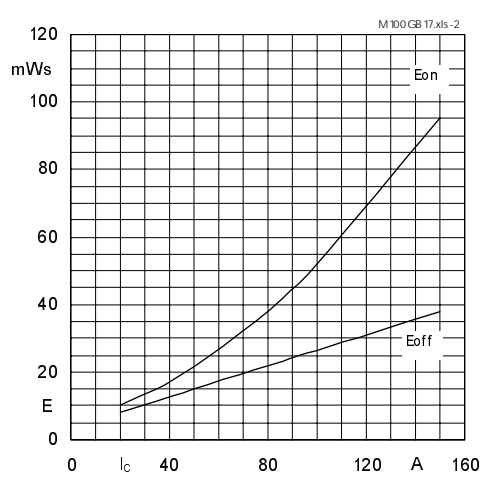


Fig. 2 Turn-on /-off energy $= f(I_C)$

$T_j = 125\text{ °C}$
 $V_{CE} = 1200\text{ V}$
 $V_{GE} = \pm 15\text{ V}$
 $R_G = 10\text{ }\Omega$

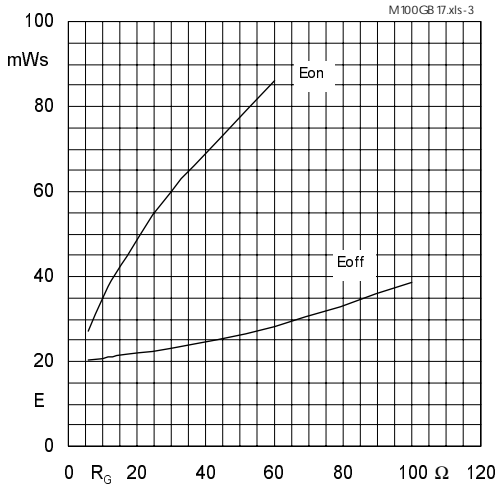


Fig. 3 Turn-on /-off energy $= f(R_G)$

$T_j = 125\text{ °C}$
 $V_{CE} = 1200\text{ V}$
 $V_{GE} = \pm 15\text{ V}$
 $I_C = 75\text{ A}$

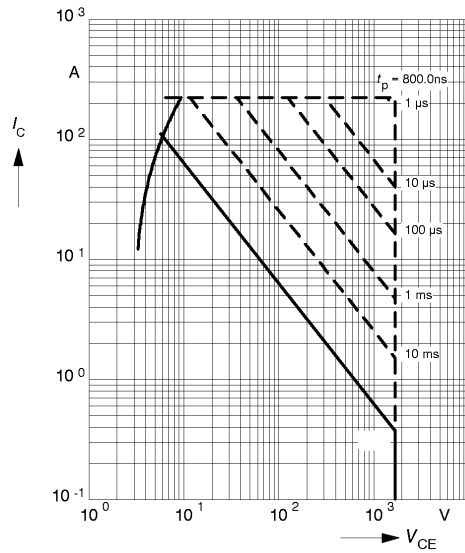


Fig. 4 Maximum safe operating area (SOA) $I_C = f(V_{CE})$

1 pulse
 $T_C = 25\text{ °C}$
 $T_j \leq 150\text{ °C}$

Not recommended for linear duty

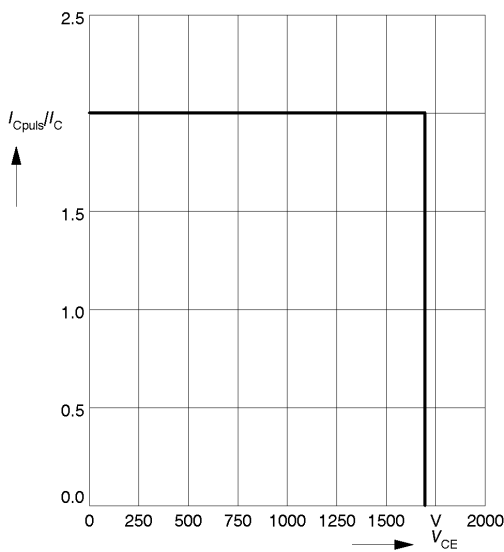


Fig. 5 Turn-off safe operating area (RBSOA)

$T_j \leq 150\text{ °C}$
 $V_{GE} = \pm 15\text{ V}$
 $R_{Goff} = 10\text{ }\Omega$
 $I_C = 75\text{ A}$

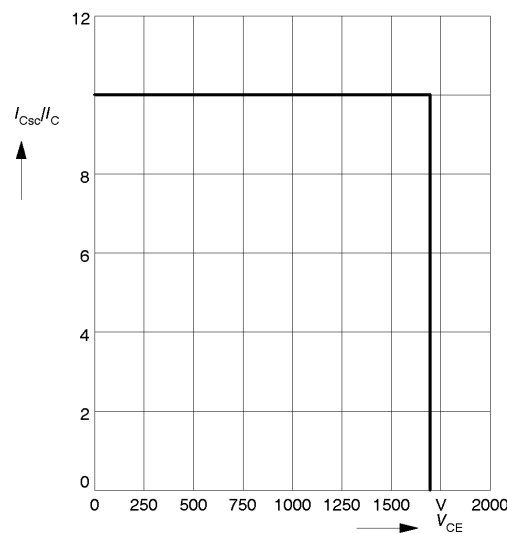


Fig. 6 Safe operating area at short circuit $I_C = f(V_{CE})$

$T_j \leq 150\text{ °C}$
 $V_{GE} = \pm 15\text{ V}$
 $t_{sc} \leq 10\text{ }\mu\text{s}$
 $L_{ext} < 50\text{ nH}$
 $I_C = 75\text{ A}$

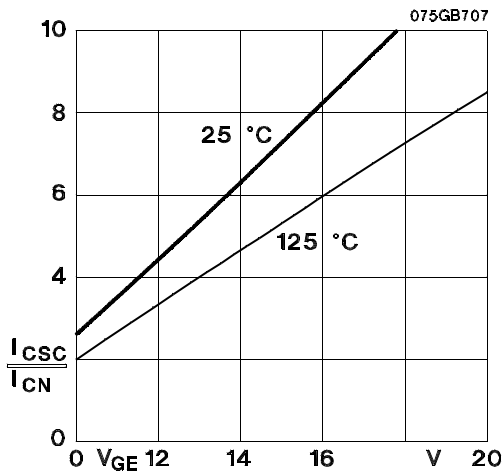


Fig. 7 Short circuit current vs. turn-on gate voltage

$V_C = 1200 \text{ V}$
 $I_C = I_{CN} = 75 \text{ A}$
 $t_p = 10 \mu\text{s}$
 $L_{\text{ext}} \leq 25 \text{ nH}$
 $R_{\text{Gon}} = 10 \Omega$
 $R_{\text{Goff}} = 10 \Omega$

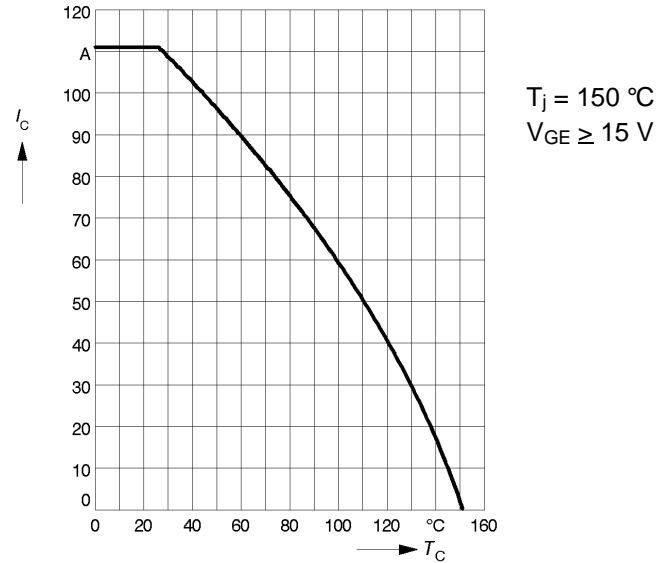


Fig. 8 Rated current vs. temperature $I_C = f(T_C)$

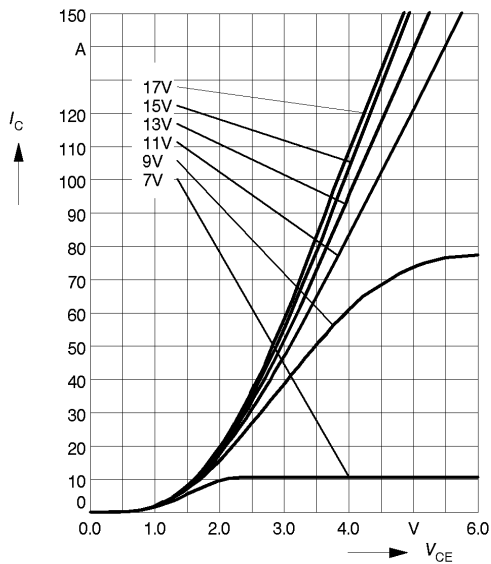


Fig. 9 Typ. output characteristic, $t_p = 80 \mu\text{s}$; $T_j = 25 \text{ }^\circ\text{C}$

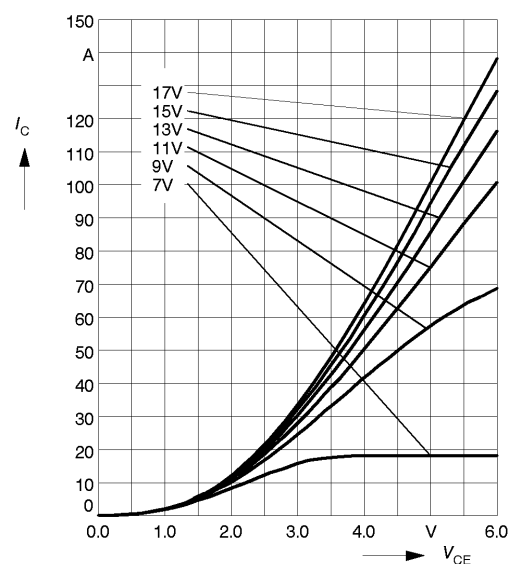


Fig. 10 Typ. output characteristic, $t_p = 80 \mu\text{s}$; $T_j = 125 \text{ }^\circ\text{C}$

$$P_{\text{cond}(t)} = V_{\text{CEsat}(t)} \cdot I_C(t)$$

$$V_{\text{CEsat}(t)} = V_{\text{CE(To)(Tj)}} + r_{\text{CE}(Tj)} \cdot I_C(t)$$

$$V_{\text{CE(To)(Tj)}} \leq 1,9 + 0,003 (T_j - 25) \text{ [V]}$$

$$r_{\text{CE}(Tj)} = 0,023 + 0,00007 (T_j - 25) \text{ [\Omega]}$$

valid for $V_{\text{GE}} = +15 \frac{+2}{-1} \text{ [V]}$; $I_C > 0,3 I_{\text{Cnom}}$

Fig. 11 Typ. saturation characteristic (IGBT)
Calculation elements and equations

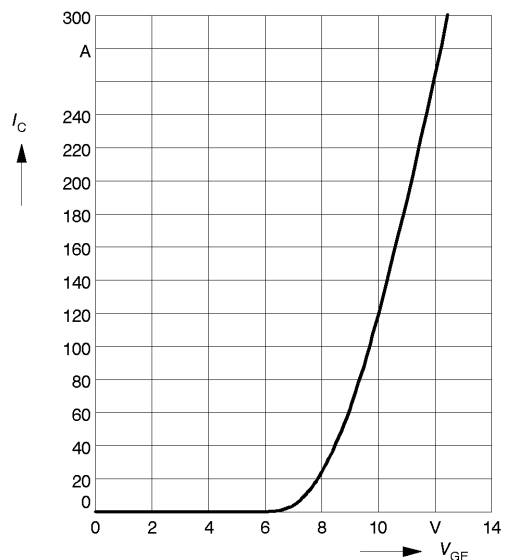


Fig. 12 Typ. transfer characteristic, $t_p = 80 \mu\text{s}$; $V_{\text{CE}} = 20 \text{ V}$

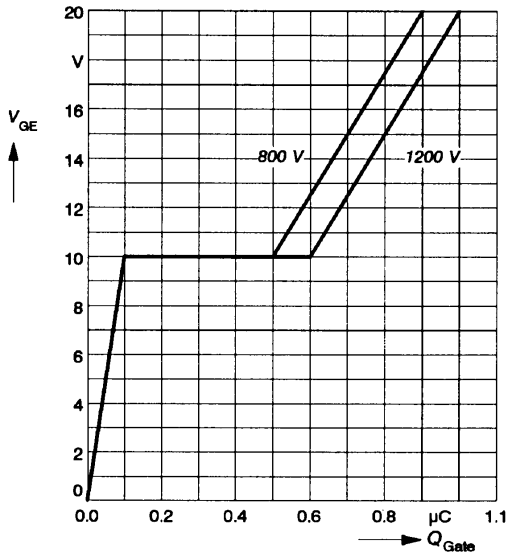


Fig. 13 Typ. gate charge characteristic

$I_{Cpuls} = 75 \text{ A}$

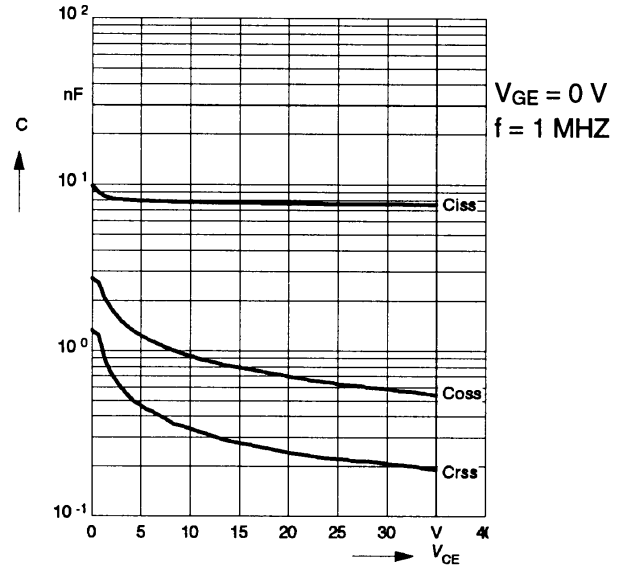


Fig. 14 Typ. capacitances vs. V_{CE}

$V_{GE} = 0 \text{ V}$
 $f = 1 \text{ MHz}$

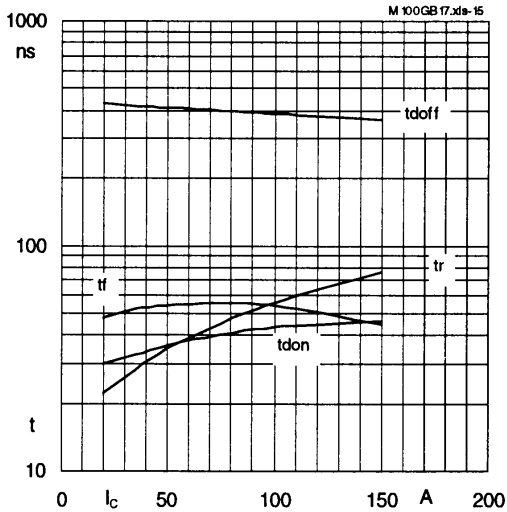


Fig. 15 Typ. switching times vs. I_c

$T_j = 125 \text{ }^\circ\text{C}$
 $V_{CE} = 1200 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_G = 10 \text{ } \Omega$
ind. load

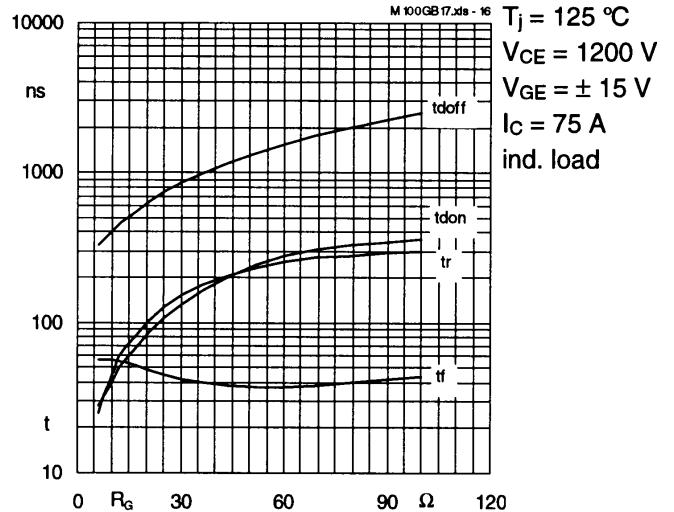


Fig. 16 Typ. switching times vs. R_G

$T_j = 125 \text{ }^\circ\text{C}$
 $V_{CE} = 1200 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $I_c = 75 \text{ A}$
ind. load

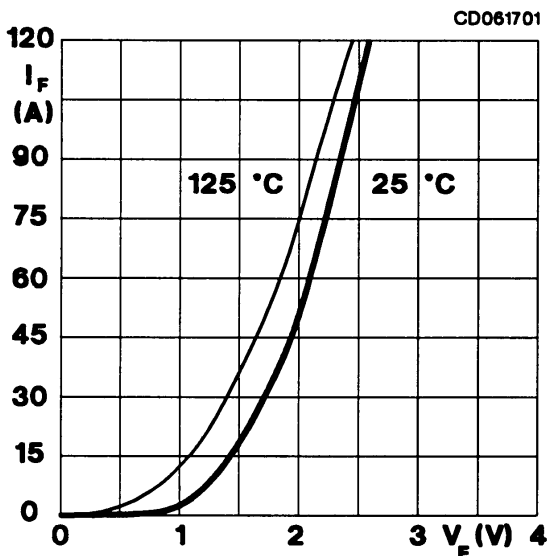


Fig. 17 Typ. CAL diode forward characteristic

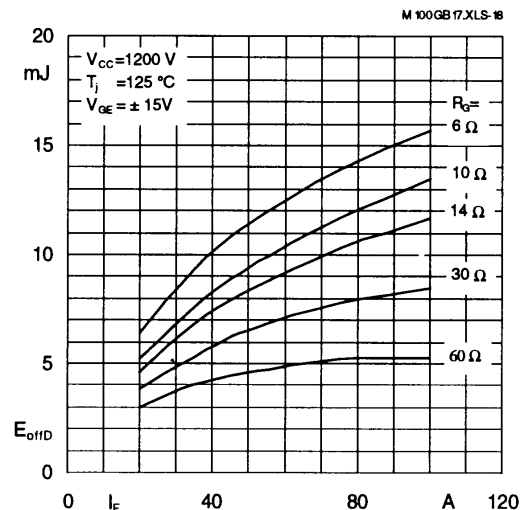


Fig. 18 Typ. Diode turn-off energy dissipation per pulse

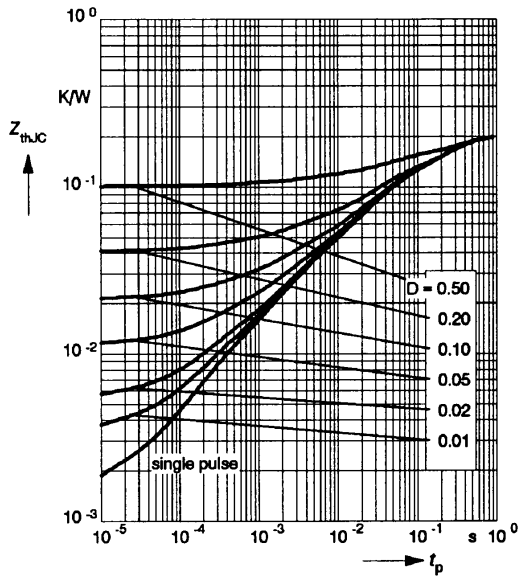


Fig. 19 Transient thermal impedance of IGBT: $Z_{thjC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

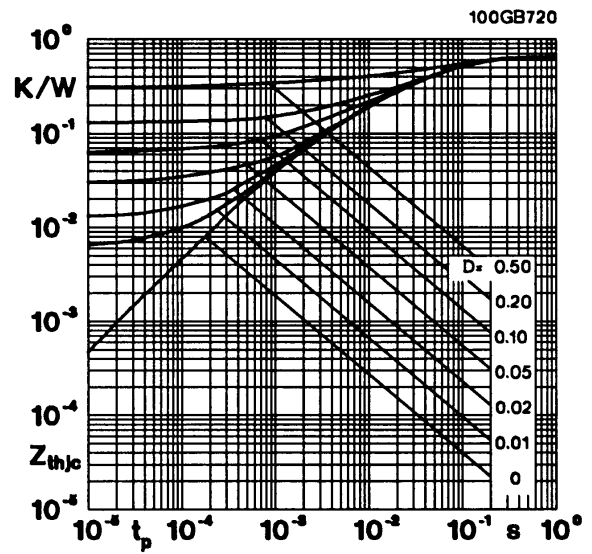


Fig. 20 Transient thermal impedance of inverse diode: $Z_{thjC} = f(t_p)$

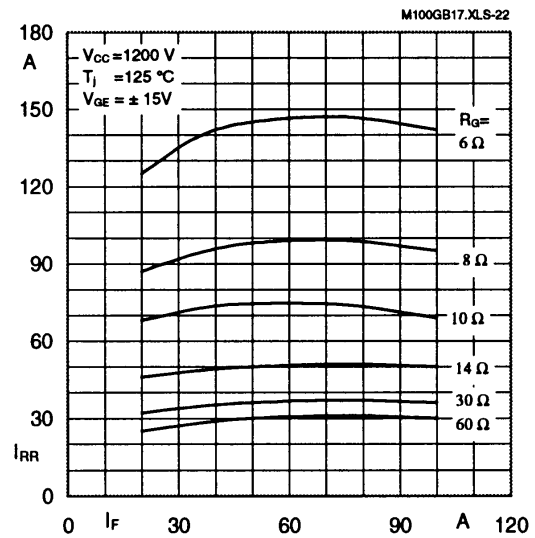


Fig. 22 Typ. CAL diode peak reverse recovery current $I_{RR} = f(I_F; R_G)$

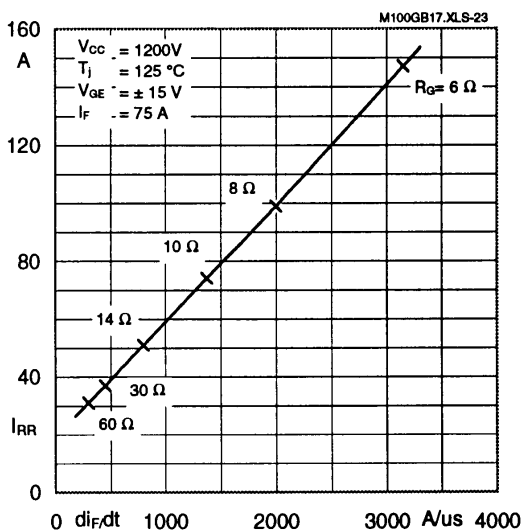


Fig. 23 Typ. CAL diode peak reverse recovery current $I_{RR} = f(di_F/dt)$

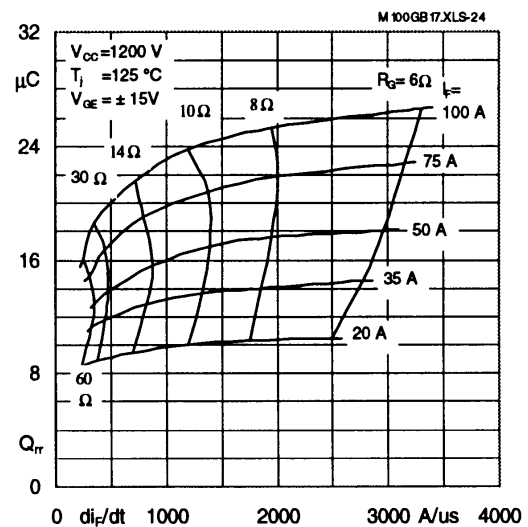


Fig. 24 Typ. CAL diode recovered charge Q_{rr}

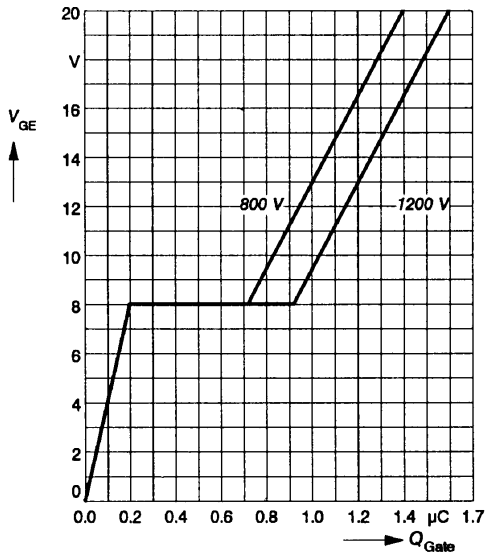


Fig. 13 Typ. gate charge characteristic

$I_{cpuls} = 100 A$

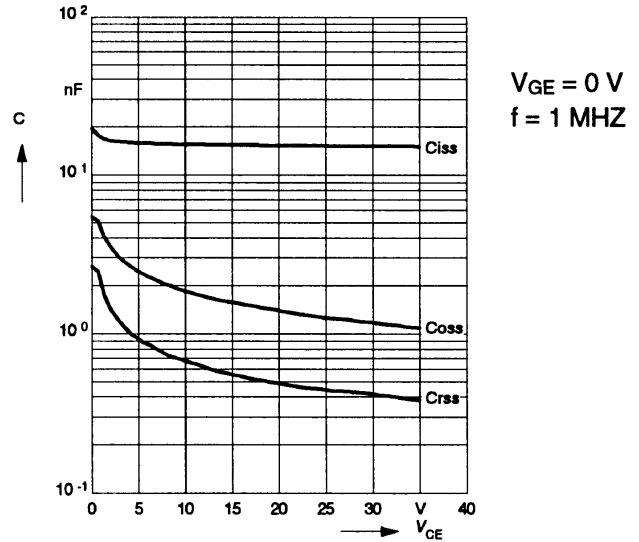


Fig. 14 Typ. capacitances vs. V_{CE}

$V_{GE} = 0 V$
 $f = 1 MHz$

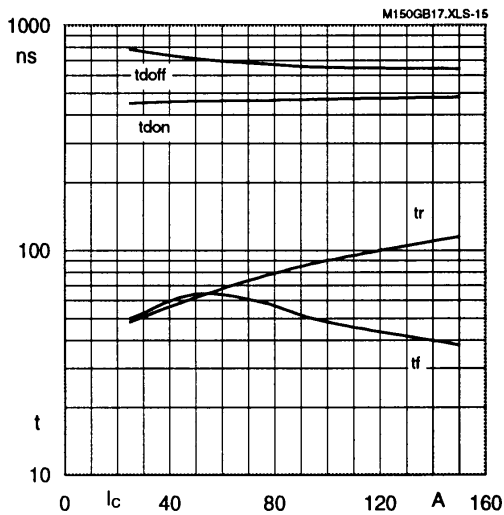


Fig. 15 Typ. switching times vs. I_c

$T_j = 125 ^\circ C$
 $V_{CC} = 1200 V$
 $V_{GE} = \pm 15 V$
 $R_g = 5 \Omega$

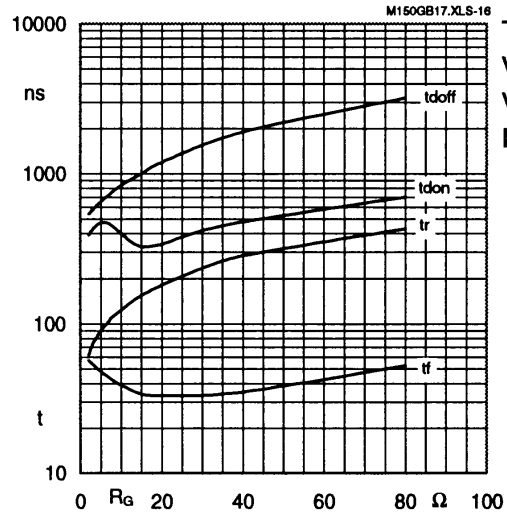


Fig. 16 Typ. switching times vs. R_g

$T_j = 125 ^\circ C$
 $V_{CC} = 1200 V$
 $V_{GE} = \pm 15 V$
 $I_c = 100 A$

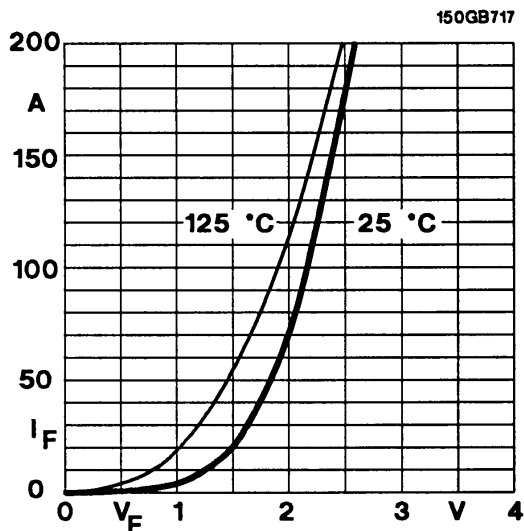


Fig. 17 Typ. CAL diode forward characteristic

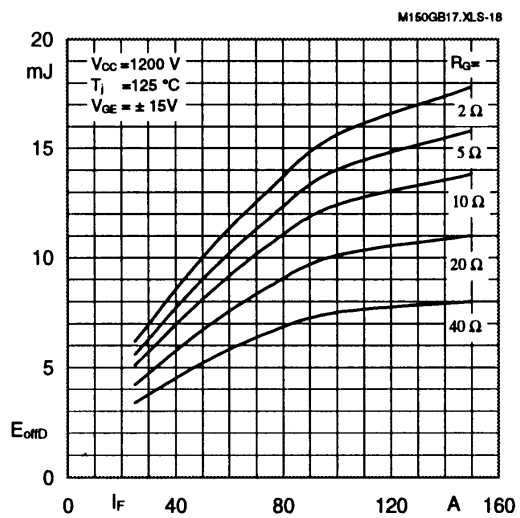


Fig. 18 Typ. Diode turn-off energy dissipation per pulse

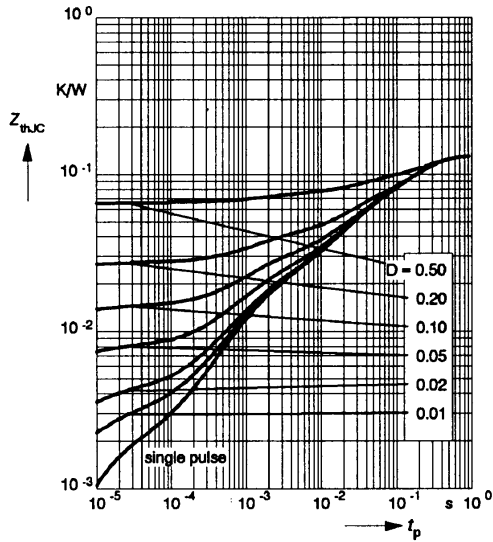


Fig. 19 Transient thermal impedance of IGBT: $Z_{thjC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

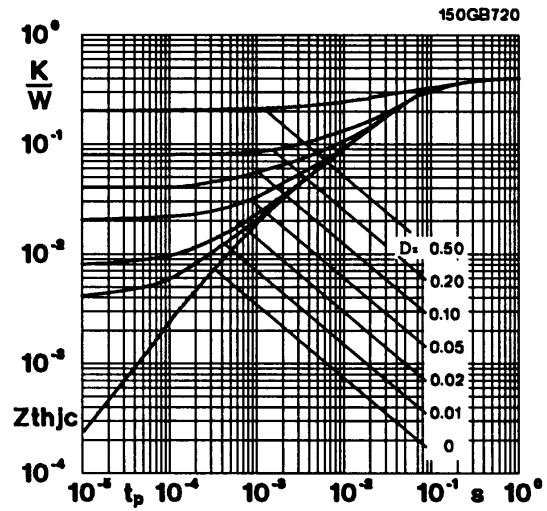


Fig. 20 Transient thermal impedance of inverse diode: $Z_{thjCD} = f(t_p)$

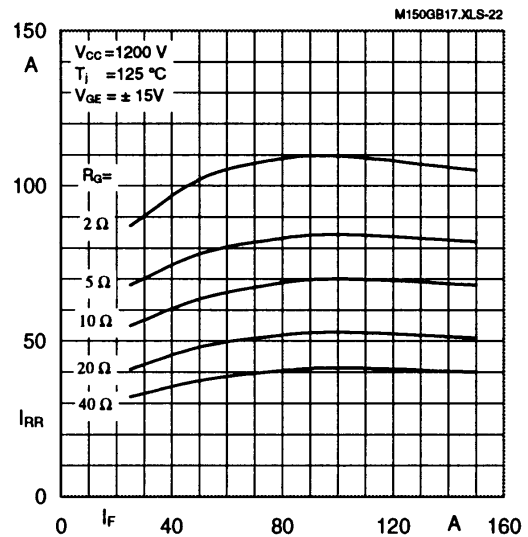


Fig. 22 Typ. CAL diode peak reverse recovery current $I_{RR} = f(I_F; R_G)$

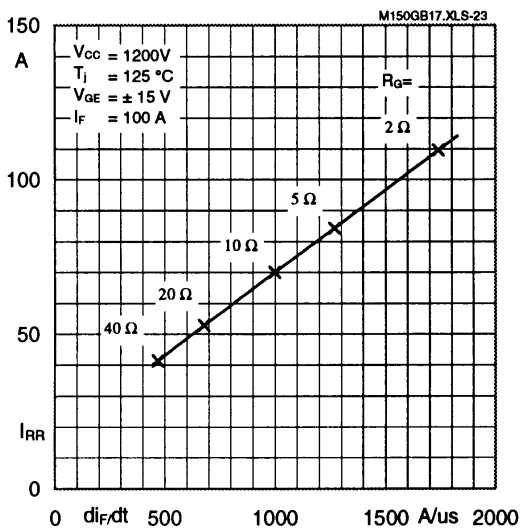


Fig. 23 Typ. CAL diode peak reverse recovery current $I_{RR} = f(di_F/dt)$

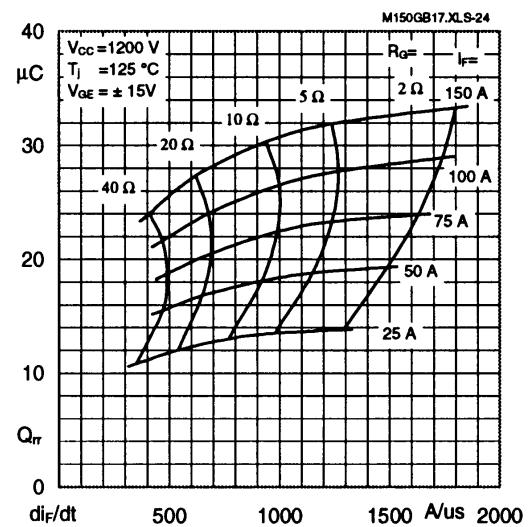


Fig. 24 Typ. CAL diode recovered charge Q_{rr} of inverse diode